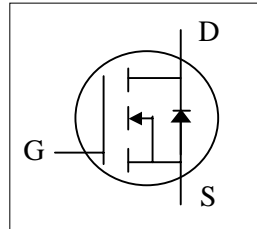


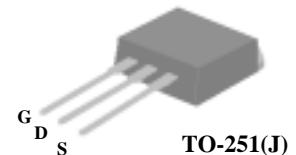
- ▼ Low Gate Charge
- ▼ Simple Drive Requirement
- ▼ Fast Switching



| | |
|--------------|--------------|
| BV_{DSS} | 25V |
| $R_{DS(ON)}$ | 25m Ω |
| I_D | 28A |

Description

The TO-252 package is universally preferred for all commercial-industrial surface mount applications and suited for low voltage applications such as DC/DC converters. The through-hole version (AP3303J) is available for low-profile applications.



Absolute Maximum Ratings

| Symbol | Parameter | Rating | Units |
|-----------------------|--|------------|---------------|
| V_{DS} | Drain-Source Voltage | 25 | V |
| V_{GS} | Gate-Source Voltage | ± 20 | V |
| $I_D@T_C=25^\circ C$ | Continuous Drain Current, V_{GS} @ 10V | 28 | A |
| $I_D@T_C=100^\circ C$ | Continuous Drain Current, V_{GS} @ 10V | 18 | A |
| I_{DM} | Pulsed Drain Current ¹ | 130 | A |
| $P_D@T_C=25^\circ C$ | Total Power Dissipation | 31 | W |
| | Linear Derating Factor | 0.25 | W/ $^\circ C$ |
| T_{STG} | Storage Temperature Range | -55 to 150 | $^\circ C$ |
| T_J | Operating Junction Temperature Range | -55 to 150 | $^\circ C$ |

Thermal Data

| Symbol | Parameter | Value | Unit |
|-----------|--|-------|--------------|
| Rthj-case | Thermal Resistance Junction-case Max. | 4.0 | $^\circ C/W$ |
| Rthj-amb | Thermal Resistance Junction-ambient Max. | 110 | $^\circ C/W$ |



AP3303H/J

Electrical Characteristics @T_j=25°C(unless otherwise specified)

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Units |
|-------------------------------------|--|--|------|------|------|-------|
| BV _{DSS} | Drain-Source Breakdown Voltage | V _{GS} =0V, I _D =250uA | 25 | - | - | V |
| ΔBV _{DSS} /ΔT _j | Breakdown Voltage Temperature Coefficient | Reference to 25°C, I _D =1mA | - | 0.02 | - | V/°C |
| R _{DS(ON)} | Static Drain-Source On-Resistance ² | V _{GS} =10V, I _D =20A | - | - | 25 | mΩ |
| V _{GS(th)} | Gate Threshold Voltage | V _{DS} =V _{GS} , I _D =250uA | 2 | - | 4 | V |
| g _{fs} | Forward Transconductance | V _{DS} =10V, I _D =20A | - | 20 | - | S |
| I _{DSS} | Drain-Source Leakage Current (T _j =25°C) | V _{DS} =25V, V _{GS} =0V | - | - | 1 | uA |
| | Drain-Source Leakage Current (T _j =150°C) | V _{DS} =20V, V _{GS} =0V | - | - | 100 | uA |
| I _{GSS} | Gate-Source Leakage | V _{GS} = ± 20V | - | - | ±100 | nA |
| Q _g | Total Gate Charge ² | I _D =20A | - | 14.5 | 24 | nC |
| Q _{gs} | Gate-Source Charge | V _{DS} = 20V | - | 3 | - | nC |
| Q _{gd} | Gate-Drain ("Miller") Charge | V _{GS} =10V | - | 8.5 | - | nC |
| t _{d(on)} | Turn-on Delay Time ² | V _{DS} =15V | - | 8.8 | - | ns |
| t _r | Rise Time | I _D =20A | - | 65 | - | ns |
| t _{d(off)} | Turn-off Delay Time | R _G =3.3Ω, V _{GS} =10V | - | 11 | - | ns |
| t _f | Fall Time | R _D =0.75Ω | - | 7 | - | ns |
| C _{iss} | Input Capacitance | V _{GS} =0V | - | 340 | 540 | pF |
| C _{oss} | Output Capacitance | V _{DS} =25V | - | 250 | - | pF |
| C _{rss} | Reverse Transfer Capacitance | f=1.0MHz | - | 98 | - | pF |

Source-Drain Diode

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Units |
|-----------------|---------------------------------|---|------|------|------|-------|
| V _{SD} | Forward On Voltage ² | I _S =20A, V _{GS} =0V | - | - | 1.5 | V |
| t _{rr} | Reverse Recovery Time | I _S =20A, V _{GS} =0V, | - | 30.5 | - | ns |
| Q _{rr} | Reverse Recovery Charge | dI/dt=100A/μs | - | 29 | - | nC |

Notes:

- 1.Pulse width limited by safe operating area.
- 2.Pulse width ≤300us , duty cycle ≤2%.

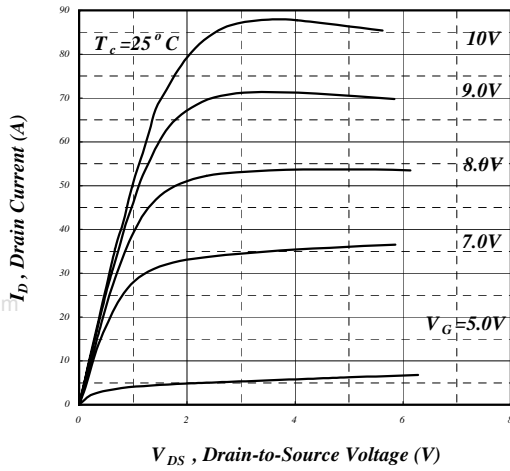


Fig 1. Typical Output Characteristics

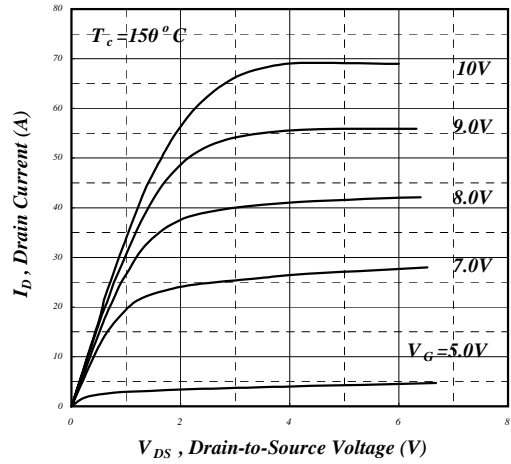


Fig 2. Typical Output Characteristics

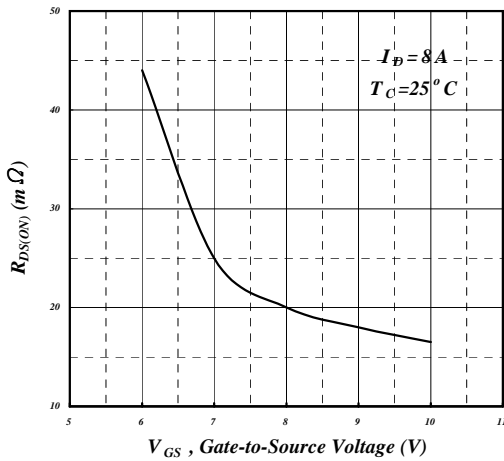


Fig 3. On-Resistance v.s. Gate Voltage

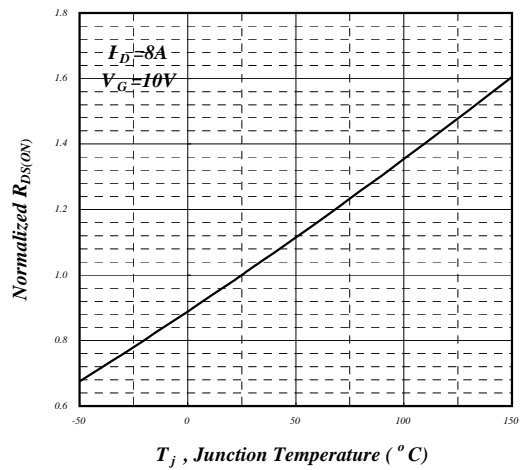


Fig 4. Normalized On-Resistance v.s. Junction Temperature

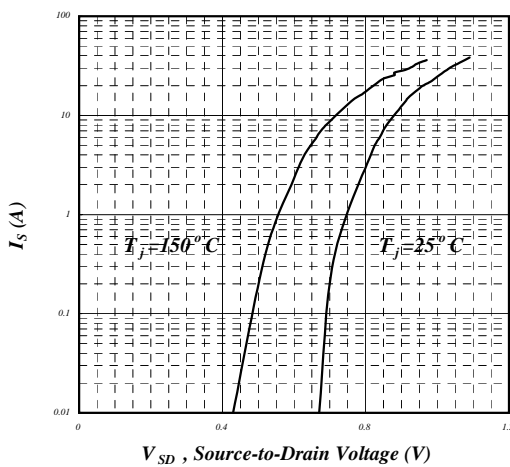


Fig 5. Forward Characteristic of Reverse Diode

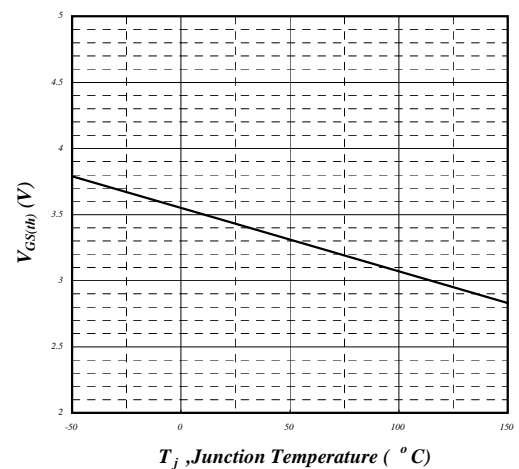


Fig 6. Gate Threshold Voltage v.s. Junction Temperature



AP3303H/J

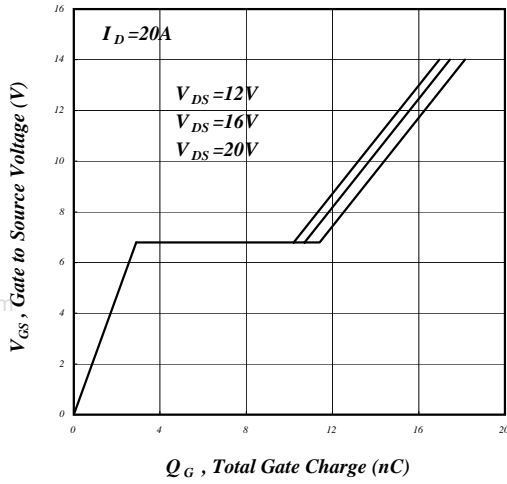


Fig7. Gate Charge Characteristics

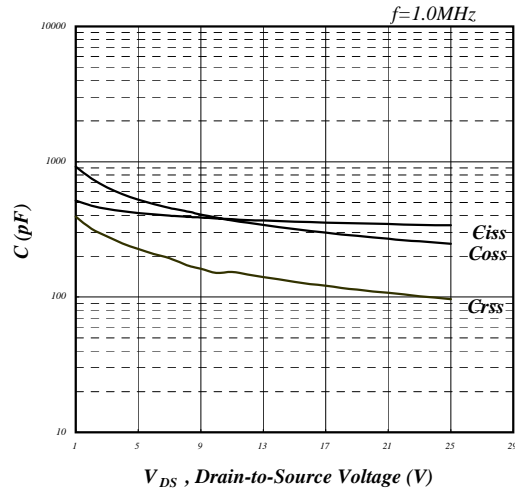


Fig 8. Typical Capacitance Characteristics

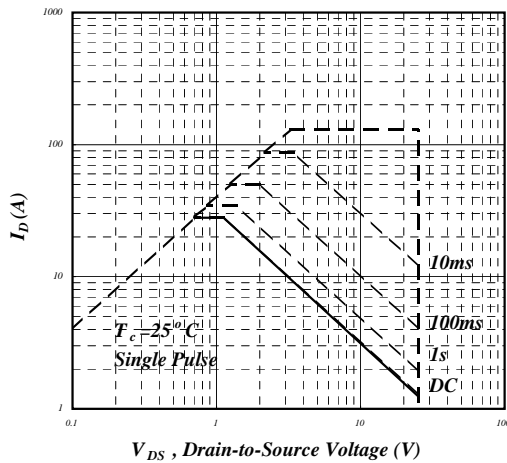


Fig 9. Maximum Safe Operating Area

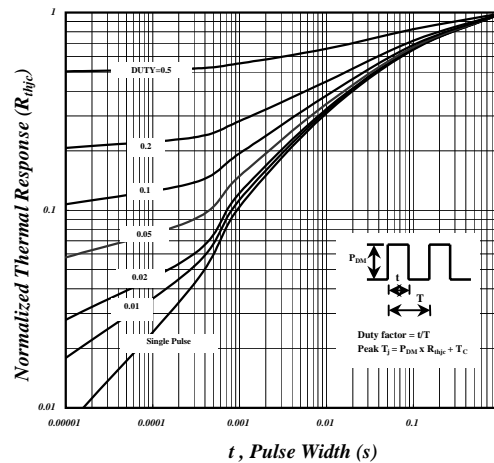


Fig 10. Effective Transient Thermal Impedance

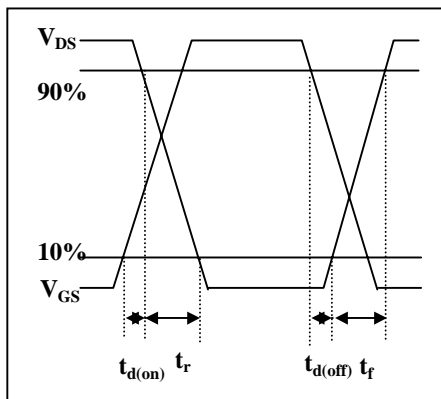


Fig 11. Switching Time Waveform

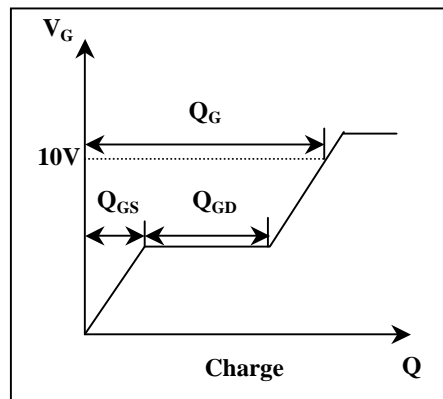


Fig 12. Gate Charge Waveform